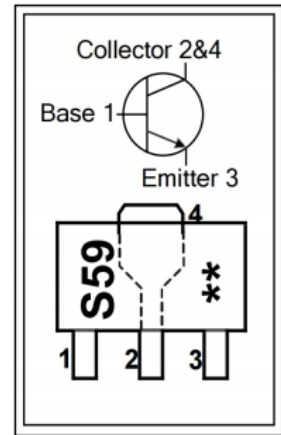


## Microwave low noise amplifier NPNsilicon epitaxial transistor

### Description :

- This chip is manufactured using silicon epitaxial technology, featuring high power gain amplification, wide bandwidth, low noise, low leakage current, small junction capacitance characteristics, a large dynamic range, and ideal current linearity.
- It is mainly applied in ultra-high frequency microwave and high frequency broadband low-noise amplifiers, such as CATV video amplifiers, wireless transceiver modules, various long-distance remote controllers, security alarms, analog-digital cordless telephones, and other related products. Suitable for medium power and high frequency signal amplification.
- Collector-emitter breakdown voltage:  $BV_{CEO} = 15V$ , maximum collector current:  $I_{CM} = 200mA$ , power dissipation:  $P_C = 2W$ , characteristic frequency:  $f_T = 8.5GHz$ .
- Package type: SOT89 Body marking (Marking): S59



### Limiting values ( $T_{amb}=25^{\circ}C$ ) :

Parameter	Symbol	Values	Unit
collector-base voltage	$V_{CBO}$	25	V
collector-emitter voltage	$V_{CEO}$	15	V
emitter-base voltage	$V_{EBO}$	2.5	V
collector current	$I_{CM}$	300	mA
power dissipation	$P_T$	2000	mW
maximum junction temperature	$T_J$	-40~150	$^{\circ}C$
storage temperature	$T_{stg}$	-65~+150	$^{\circ}C$

### Electrical parameters and characteristics ( $T_{amb}=25^{\circ}C$ ) :

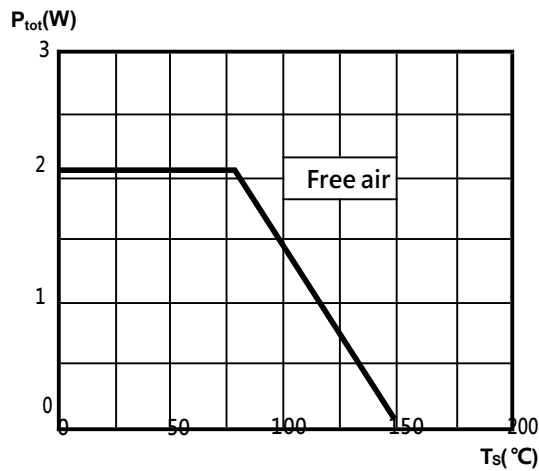
Parameter	Symbol	Test conditions	Min.	Typ.	Max.	Unit
collector-base breakdown voltage	$BV_{CBO}$	open emitter	25	35		V
collector-emitter breakdown voltage	$BV_{CEO}$	open base	15	19		V
emitter-base breakdown voltage	$BV_{EBO}$	open collector	2.5	3.5		V
collector current	$I_C$				200	mA
collector cut-off current	$I_{CBO}$	$V_{CB}=6V, I_E=0$	-	-	0.05	$\mu A$
DC current amplification factor	$h_{FE}$	$V_{CE}=8V, I_C=80mA,$	60	130	300	
characteristic frequency	$f_T$	$V_{CE}=8V, I_C=80mA, f=900MHz$	8	8.5	-	GHz
feedback capacitor	$C_{re}$	$I_C=I_C=0, V_{CB}=8V, f=1MHz$	-	1.2	-	pF
collector capacitance	$C_C$	$I_E=I_E=0, V_{CB}=8V, f=1MHz$	-	1.8	-	pF
emitter capacitance	$C_e$	$I_C=I_C=0, V_{EB}=0.5V, f=1MHz$	-	3	-	pF
insertion power gain	$ S_{21} ^2$	$I_C=80mA, V_{CE}=8V, f=433MHz$	17	18	-	
		$I_C=80mA, V_{CE}=8V, f=900MHz$	11	12	-	dB
		$I_C=80mA, V_{CE}=8V, f=1800MHz$	5	5.5	-	
maximum unilateral power gain	$G_{UM}$	$I_C=80mA, V_{CE}=8V, f=433MHz$	18	19.5	-	
		$I_C=80mA, V_{CE}=8V, f=900MHz$	11.5	12.5	-	dB
		$I_C=80mA, V_{CE}=8V, f=1.8GHz$	6.5	7	-	

Among them:  $G_{UM} = 10 \log \frac{|S_{21}|^2}{(1 - S_{11})^2 (1 - S_{22})^2} dB$

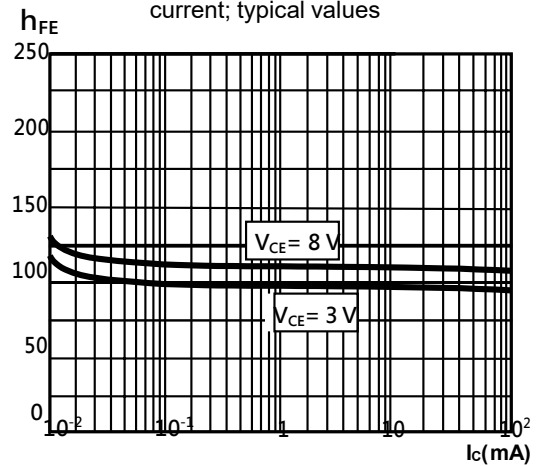
Typical characteristic:

## Typical characteristics (TA=25°C, unless otherwise specified)

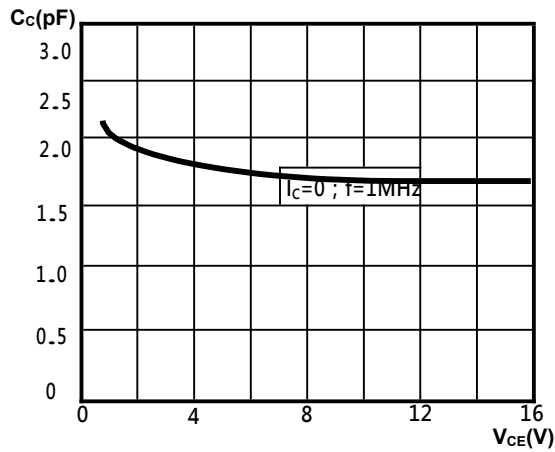
Power derating curve



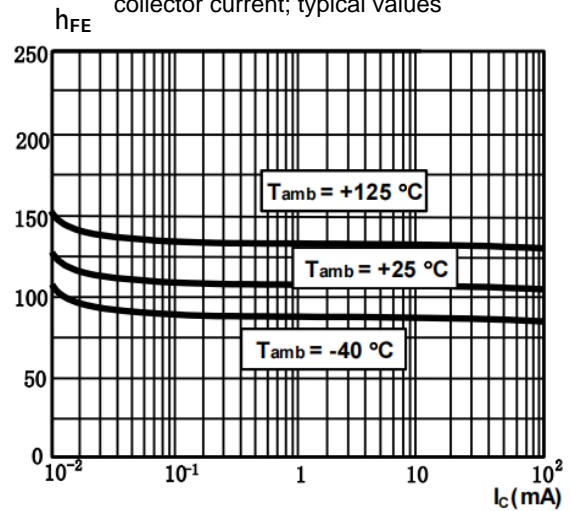
DC current gain as a function of collector current; typical values



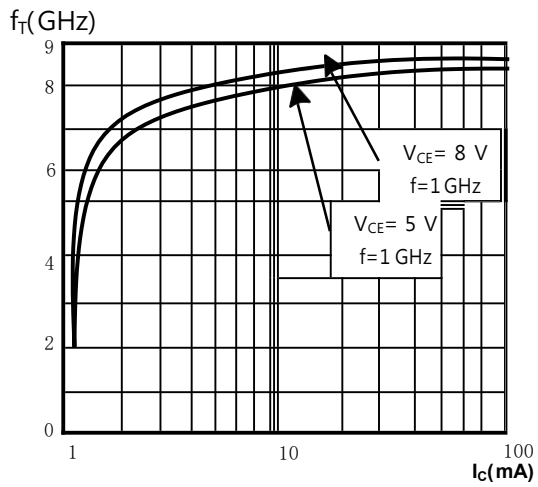
Collector capacitance as a function of collector-base voltage; typical values



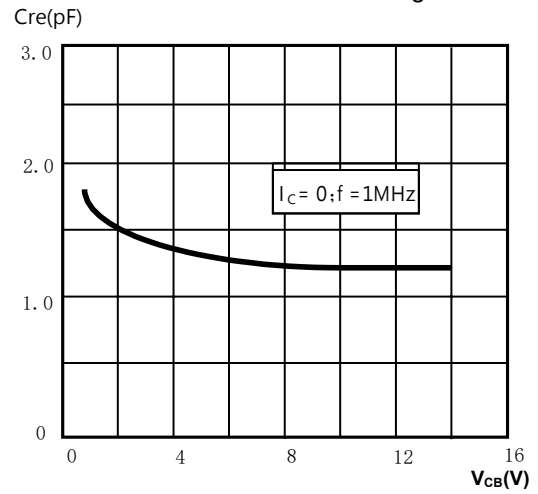
DC current gain as a function of collector current; typical values



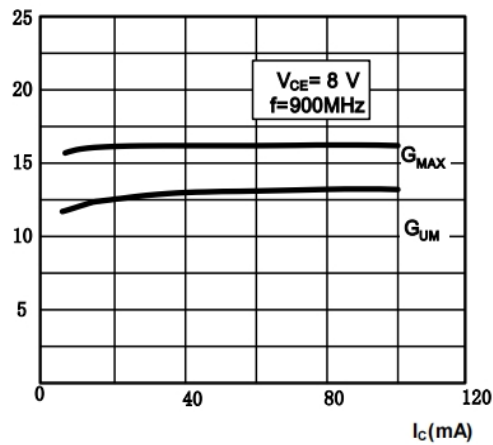
Frequency collector vs. Current



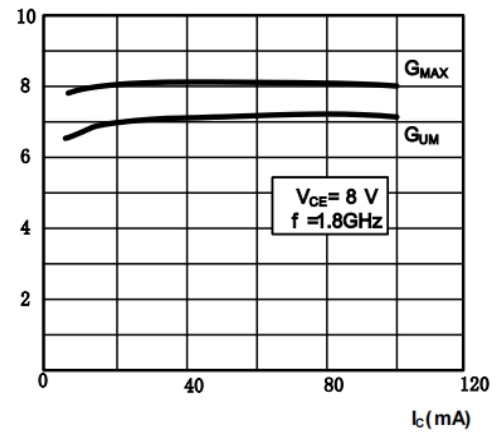
Reverse transfer capacitance vs. Collector to base voltage



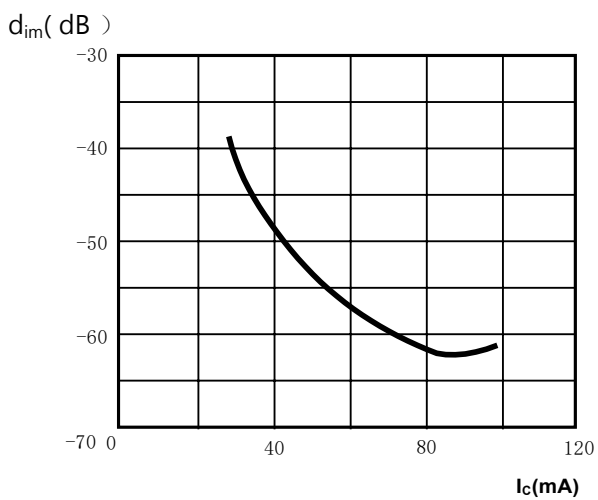
Gain vs. Function of collector current



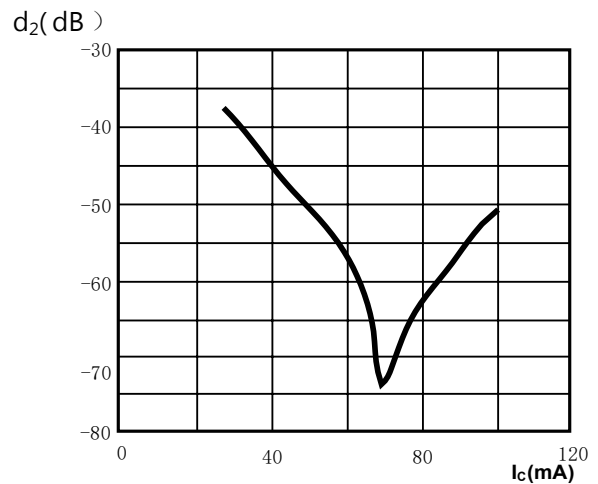
Gain vs. Function of collector current



Intermodulation distortion vs. Function of collector current

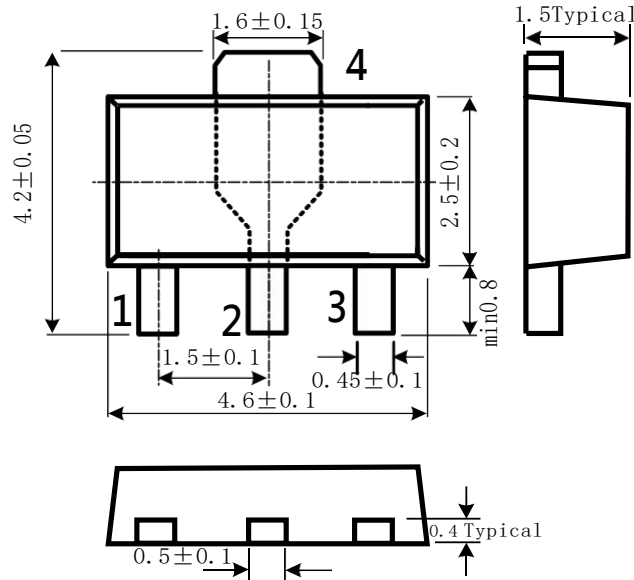


Second order intermodulation distortion vs. Function of collector current



Package dimensions diagram :

**SOT-89 package dimensions**  
(Units:mm)



**Pin connections**

1.Base 2&4.collector 3.emitter